

# The Kenya National Examinations Council



**DIRECTOR**  
**QUALITY ASSURANCE AND STANDARDS**  
**MINISTRY OF EDUCATION**  
P.O. Box 30426 - 00100,  
Nairobi  
21/10/20

This is to certify that the candidate named below sat for the Kenya Certificate of Secondary Education examination in the subjects named below and qualified for the award of a

**Kenya**

## Certificate of Secondary Education

THE CANDIDATE REACHED THE GRADE SHOWN IN THE SUBJECTS NAMED

**WANGILA NALYANYA ALFRED**

**\*M\* 62083/035**

**NAMAWANGA GIRLS SECONDARY SCHOOL**

**GRADE**

- 101 ENGLISH**
- 102 KISWAHILI**
- 111 HISTORY AND GOVERNMENT**
- 112 GEOGRAPHY**
- 121 MATHEMATICS**
- 134 PHYSICAL SCIENCE**
- 135 BIOLOGICAL SCIENCES**
- 212 CHRISTIAN RELIGIOUS EDUCATION**
- 332 AGRICULTURE**
- 427 ECONOMICS**

- D-(MINUS)**
- D (PLAIN)**
- D (PLAIN)**
- D (PLAIN)**
- E**
- D-(MINUS)**
- D-(MINUS)**
- C-(MINUS)**
- D (PLAIN)**
- E**

**SUBJECTS NAMED TEN**

**MEAN GRADE D (PLAIN)**

**EXAMINATION OF NOVEMBER/DECEMBER 1989**

**Secretary**

**Kenya National Examinations Council**

*Philip M. Mbiti*

**Chairman**

**Kenya National Examinations Council**

**KCSE 100872**

(See overleaf)



KCSE

DIRECTOR  
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P. O. Box 30426 - 00100,  
TEL: 318581  
NAIROBI

## AWARD OF CERTIFICATE

21/10/20

Certificates awarded to candidates for the examination show:

- (a) the name of the candidate,
- (b) the candidate's index number,
- (c) the name of the school for school candidates only,
- (d) all the subjects taken by the candidate in the examination,
- (e) attainment in each of the subjects taken (Grades A to E),
- (f) the mean grade attained by the candidate, and
- (g) the year of the examination.

Attainment in a subject is indicated by a grade of which grade A is the highest and grade E is the lowest.

Grade A Very Good  
A-

Grade B+ Good  
B  
B-

Grade C+ Average  
C  
C-  
D+

Grade D Weak  
D-

Grade E Poor

The word SUPPLEMENTARY on the front of the certificate indicates that the candidate sat for the examination on a second or subsequent occasion.